

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	7	"743349".ap.	US-PGPUB; USPAT	OR	OFF	2005/09/08 15:23
S1	12	test\$4 with (IC or (integrated near circuit)) and captur\$4 with waveform and filter\$4 with sampl\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 10:55
S2	0	test\$4 with (IC or (integrated near circuit)) and captur\$4 with waveform and filter\$4 same sampl\$4 same voltage same current same multiplier	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 12:29
S3	0	test\$4 with (IC or (integrated near circuit)) and captur\$4 with waveform and filter\$4 same sampl\$4 same voltage same current	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 13:35
S4	1	test\$4 with (IC or (integrated near circuit)) and captur\$4 with waveform and filter\$4 same sampl\$4 and voltage with current with convert\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 13:48
S5	51	captur\$4 with waveform and filter\$4 same sampl\$4 and voltage with current with convert\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 13:48
S6	10	captur\$4 with waveform and filter\$4 same sampl\$4 same voltage with current with convert\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 13:49
S7	8	captur\$4 with waveform and filter\$4 same sampl\$4 same voltage with current with convert\$4 and (Ic (integrated near circuit))	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 13:50
S8	289	filter\$4 same sampl\$4 same voltage with current with convert\$4 and (Ic (integrated near circuit))	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:01
S9	5	filter\$4 same sampl\$4 same voltage with current with convert\$4 and (Ic (integrated near circuit)) with test\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:08
S10	179	filter\$4 same sampl\$4 same voltage with current with convert\$4 and (Ic (integrated near circuit)) and waveform	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:11

S11	87	filter\$4 same sampl\$4 same voltage with current with convert\$4 and (Ic (integrated near circuit)) and waveform and test\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:12
S12	54	filter\$4 same sampl\$4 same voltage with current with convert\$4 and (Ic (integrated near circuit)) and waveform and test\$4 with circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:20
S13	2	filter\$4 same sampl\$4 same voltage near current near convert\$4 and (Ic (integrated near circuit)) and waveform and test\$4 with circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:24
S14	0	filter\$4 same sampl\$4 same voltage near current near convert\$4 and multiplier near current and (Ic (integrated near circuit)) and test\$4 with circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:19
S15	0	filter\$4 same sampl\$4 same voltage near current near convert\$4 and multiplier near current and test\$4 with circuit and analy\$4 with waveform	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:20
S16	0	filter\$4 same sampl\$4 same voltage near current near convert\$4 and test\$4 with circuit and analy\$4 with waveform	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:20
S17	0	filter\$4 same sampl\$4 same voltage with current with convert\$4 and (Ic (integrated near circuit)) and waveform with analy\$4 and test\$4 with circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:20
S18	4	filter\$4 same sampl\$4 same voltage near current near convert\$4 and waveform and test\$4 with circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 14:39
S19	23	filter\$4 same sampl\$4 and waveform near captur\$4 and test\$4 with circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 15:41
S20	1623	filter\$4 same sampl\$4 and waveform and test\$4 with circuit and second	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 15:38
S21	284	filter\$4 same sampl\$4 and oscilloscope and test\$4 with circuit and second	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 15:39

S22	89	filter\$4 same sampl\$4 and oscilloscopes! and test\$4 with circuit and second	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 15:52
S23	108	filter\$4 same sampl\$4 and signal near captur\$4 and test\$4 with circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 15:41
S24	4	filter\$4 same sampl\$4 and test\$4 with circuit and second near oscilloscope	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 16:08
S25	8	filter\$4 same sampl\$4 and test\$4 and second near oscilloscope	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 16:24
S26	17	filter\$4 same sampl\$4 and test\$4 and two near oscilloscope	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 16:29
S27	29	filter\$4 same sampl\$4 and test\$4 and two near path and (wave waveform) with captur\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 16:50
S28	190	process\$4 with signals! and filter\$4 same sampl\$4 and oscilloscopes!	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 16:51
S29	62	process\$4 with signals! and filter\$4 same sampl\$4 and oscilloscopes! and stages!	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 16:51
S30	52	process\$4 with signals! and filter\$4 same sampl\$4 and oscilloscopes! and stages! and test\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 16:52
S31	113	process\$4 with signals! and filter\$4 same sampl\$4 and (wave waveform) with captur\$4 and stages! and test\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/02 16:52
S32	17	process\$4 with signals! and filter\$4 same sampl\$4 and (wave waveform) with captur\$4 and stages! and test\$4 with circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:17
S33	0	test\$4 with circuit and filter\$4 same sampl\$4 same stage and (wave waveform) near capture	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:18

S34	5	test\$4 with circuit and filter\$4 same sampl\$4 and stage and (wave waveform) near capture	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:28
S35	14	test\$4 with circuit and filter\$4 and sampl\$4 and stage and (wave waveform) near capture	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:34
S36	27	test\$4 with circuit and filter\$4 and sampl\$4 and (wave waveform) near capture	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:35
S37	13	test\$4 with circuit and filter\$4 and sampl\$4 and (wave waveform) near capture not stage	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:41
S38	150	waveform with capture with device	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:39
S39	7	"743349".ap.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:39
S40	679	test\$4 with circuit and filter\$4 and sampl\$4 and oscilloscope	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:41
S41	5	test\$4 with circuit and filter\$4 and sampl\$4 and oscilloscope and voltage near current near convert\$4 and multiplier	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 10:44
S42	8	stage and filter\$4 and sampl\$4 and oscilloscope and voltage near current near convert\$4 and multiplier	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 11:11
S43	8	filter\$4 and sampl\$4 and oscilloscope and voltage near current near convert\$4 and multiplier and test\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 11:18
S44	9	filter\$4 same voltage near current near convert\$4 same current near multiplier	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/08 11:03
S45	2	"6791399".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/03 11:21

S46	4	"705638".ap.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/08 11:03
S47	2	filter\$3 with sampl\$4 and variable near offset with skew	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 10:38
S48	240	filter\$3 with sampl\$4 and variable near offset	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 10:38
S49	2	filter\$3 with sampl\$4 and variable near offset with reference near current	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 10:39
S50	15	filter\$3 with sampl\$4 and variable near offset with current	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 10:47
S51	22	filter\$3 same sampl\$4 and variable near offset with current	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 10:52
S52	2	filter\$3 and sampl\$4 and variable near offset with current with skew	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 10:59
S53	42	filter\$3 and sampl\$4 and variable near offset with current	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 10:58
S54	4	filter\$3 and sampl\$4 and variable near offset with current with reference	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 10:54
S55	2	variable near offset with current with skew	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 10:59
S56	12	variable near offset with current with reference	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:02
S57	4	variable near offset with current with reference and sampl\$4 and filter\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:05

S58	1685	filter\$3 with device same sampl\$3 with circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:06
S59	2	filter\$3 with device same sampl\$3 with circuit and waveform near captur\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:06
S60	1	filter\$3 with device same sampl\$3 with circuit and variable near offset	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:06
S61	41	filter\$3 with device same sampl\$3 with circuit and oscilloscope	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:08
S62	0	filter\$3 near device same sampl\$3 near circuit and oscilloscope	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:08
S63	19	filter\$3 near device same sampl\$3 near circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:48
S64	1	filter\$3 near device same sampl\$3 near circuit and variable near offset	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:49
S65	514	filter\$3 and sampl\$3 and variable near offset	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:49
S66	42	filter\$3 and sampl\$3 and variable near offset with current	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/02 11:49
S67	22	filter\$3 same sampl\$3 and variable near offset with current	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:04
S68	42	filter\$3 and sampl\$3 and variable near offset with current	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:09
S69	10571	filter\$3 same sampl\$4 same stage	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:09

S70	0	filter\$3 same sampl\$4 same stage same waveform near captur\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:09
S71	7	filter\$3 same sampl\$4 same stage and waveform near captur\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:11
S72	135	filter\$3 same sampl\$4 and waveform near captur\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:11
S73	14	filter\$3 same sampl\$4 same waveform near captur\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:41
S74	0	filter\$3 adj4 then adj4 sampl\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:42
S75	0	filter\$3 with then with sampl\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:42
S76	3875	filter\$3 with prior with sampl\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:42
S77	0	filter\$3 with prior with sampl\$4 same wave\$4 near captur\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 11:43
S78	63	filter\$3 with prior with sampl\$4 same captur\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 14:26
S79	31	filter\$3 with prior with sampl\$4 same captur\$4 and differential	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/07 14:26
S80	20069	((integrated near circuit) or ic) and network and filter\$3 and sampl\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/08 10:29
S81	71	((integrated near circuit) or ic) and network and filter\$3 and sampl\$3 and waveform near captur\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/08 10:29

S82	71	((integrated near circuit) or ic) and network and filter\$3 and sampl\$3 and waveform near captur\$4 and process\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/08 10:29
S83	45	((integrated near circuit) or ic) and network and filter\$3 same sampl\$3 and waveform near captur\$4 and process\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/09/08 10:29